



# PRODUCT DATA SHEET



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Datasheet

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Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO\_questions@jgsemi.com.



#### **General Description**

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

BVDSS	RDSON	ID
30V	$1.0$ m $\Omega$	240A

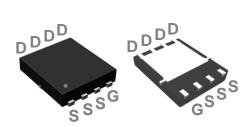
#### **Features**

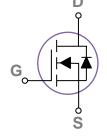
- 30V,240A,  $RDS(ON) = 1.0m\Omega@VGS = 10V$
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

# **Applications**

- Networking
- Load Switch
- LED applications

### **PDFN5X6 Pin Configuration**





### Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V <sub>DS</sub>	Drain-Source Voltage	30	V
V <sub>G</sub> s	Gate-Source Voltage	+20/-20	V
I_	Drain Current – Continuous (T <sub>C</sub> =25°C)	240	А
lD	Drain Current – Continuous (Tc=100°C)	150	Α
I <sub>DM</sub>	Drain Current – Pulsed <sup>1</sup>	960	А
EAS	Single Pulse Avalanche Energy <sup>2</sup>	540	mJ
IAS	Single Pulse Avalanche Current <sup>2</sup>	104	А
Б	Power Dissipation (T <sub>C</sub> =25°C)	178	W
P <sub>D</sub>	Power Dissipation – Derate above 25°C	1.43	W/°C
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

#### **Thermal Characteristics**

Symbol	Symbol Parameter		Max.	Unit
Reja	Thermal Resistance Junction to ambient		62	°C/W
Rejc	Thermal Resistance Junction to Case		0.7	°C/W



# **Electrical Characteristics** (T<sub>J</sub>=25 °C, unless otherwise noted)

#### **Off Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	30			V
I <sub>DSS</sub> Drain-Source Leakage C	Dunin Course Leakens Coursest	V <sub>DS</sub> =30V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			1	uA
	Diam-Source Leakage Current	V <sub>DS</sub> =24V , V <sub>GS</sub> =0V , T <sub>J</sub> =125°C			10	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> =20V , V <sub>DS</sub> =0V			100	nA

#### **On Characteristics**

R <sub>DS(ON)</sub> Static Drain-	Static Drain-Source On-Resistance	$V_{GS}$ =10V , $I_D$ =30A		1.0	1.4	mΩ
	Static Dialii-Source Off-Resistance	V <sub>GS</sub> =4.5V , I <sub>D</sub> =15A		1.4	4.0	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA	1	1.8	2.5	V
gfs	Forward Transconductance	V <sub>DS</sub> =10V , I <sub>D</sub> =3A		15		S

#### **Dynamic and switching Characteristics**

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$Q_g$	Total Gate Charge <sup>3, 4</sup>		 73	
$Q_{gs}$	Gate-Source Charge <sup>3,4</sup>	V <sub>DS</sub> =15V , V <sub>GS</sub> =10V , I <sub>D</sub> =80A	 15	 nC
$Q_gd$	Gate-Drain Charge <sup>3, 4</sup>		 12	
T <sub>d(on)</sub>	Turn-On Delay Time <sup>3, 4</sup>		 20	
Tr	Rise Time <sup>3, 4</sup>	$V_{DD}$ =15 $V$ , $V_{GS}$ =10 $V$ , $R_{G}$ =6 $\Omega$	 15	 20
$T_{d(off)}$	Turn-Off Delay Time <sup>3, 4</sup>	I <sub>D</sub> =80A	 30	 ns
Tf	Fall Time <sup>3, 4</sup>		 25	
Ciss	Input Capacitance		 5090	
Coss	Output Capacitance	$V_{DS}$ =15V , $V_{GS}$ =0V , F=1MHz	 2050	 pF
Crss	Reverse Transfer Capacitance		 85	
$R_g$	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, F=1MHz	 1.5	 Ω

# **Drain-Source Diode Characteristics and Maximum Ratings**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			240	Α
I <sub>SM</sub>	Pulsed Source Current	VG=VD=UV, FOICE Current			480	Α
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25°C			1.3	V
t <sub>rr</sub>	Reverse Recovery Time	Vr=30V, Is=10A		150		ns
Qrr	Reverse Recovery Charge	di/dt=100A/µs, Tյ=25°C		300		nC

#### Note:

- 1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
- 2.  $V_{DD}$ =25V, $V_{GS}$ =10V,L=0.1mH, $I_{AS}$ =104A., $R_{G}$ =25 $\Omega$ ,Starting  $T_{J}$ =25 $^{\circ}$ C.
- 3. The data tested by pulsed , pulse width  $\,\leq\,$  300us , duty cycle  $\,\leq\,$  2%.
- 4. Essentially independent of operating temperature.



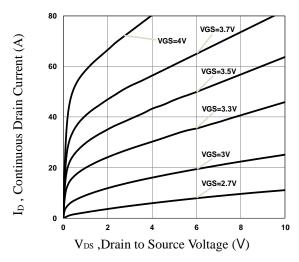


Fig.1 Typical Output Characteristics

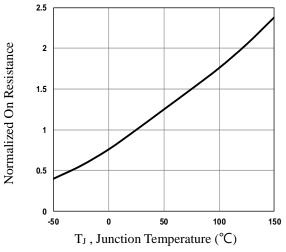


Fig.3 Normalized RDSON vs. T<sub>J</sub>

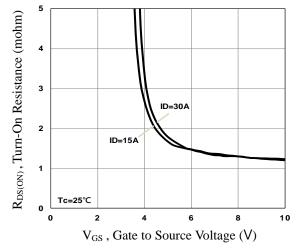


Fig.5 Turn-On Resistance vs. V<sub>GS</sub>

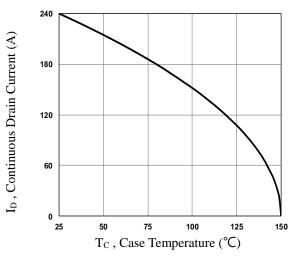


Fig.2 Continuous Drain Current vs. Tc

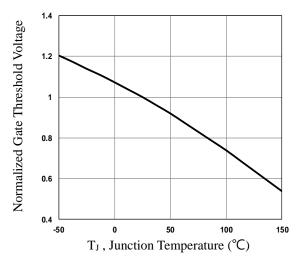


Fig.4 Normalized  $V_{th}$  vs.  $T_J$ 

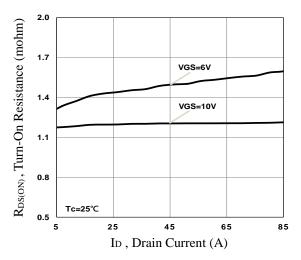


Fig.6 Turn-On Resistance vs. ID



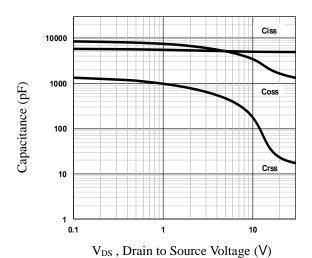
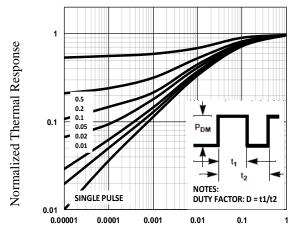


Fig.7 Capacitance Characteristics



Square Wave Pulse Duration (s)

Fig.9 Normalized Transient Impedance

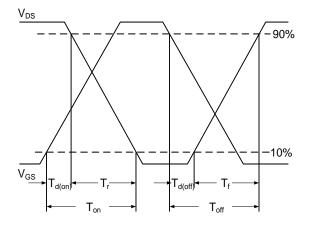


Fig.11 Switching Time Waveform

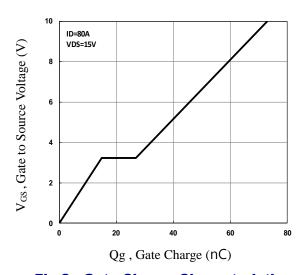
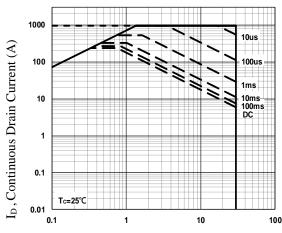


Fig.8 Gate Charge Characteristics



V<sub>DS</sub>, Drain to Source Voltage (V)

Fig.10 Maximum Safe Operation Area  $BV_{DSS}$ 

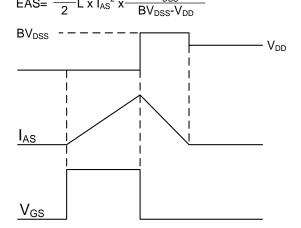
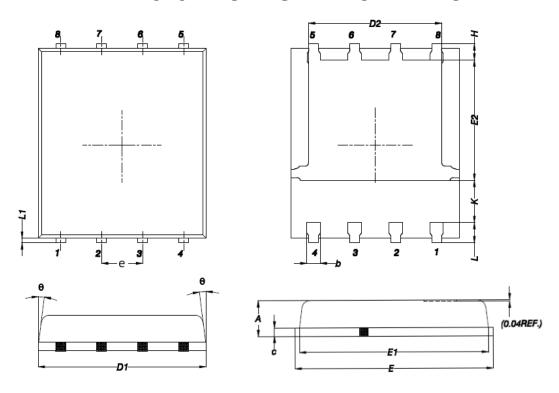


Fig.12 EAS Waveform



# PPAK5x6 PACKAGE INFORMATION



Symbol	Dimensions I	n Millimeters	Dimension	s In Inches
	MAX	MIN	MAX	MIN
Α	1.200	0.850	0.047	0.031
b	0.510	0.300	0.020	0.012
С	0.300	0.200	0.012	0.008
D1	5.400	4.800	0.212	0.189
D2	4.310	3.610	0.170	0.142
E	6.300	5.850	0.248	0.230
E1	5.960	5.450	0.235	0.215
E2	3.920	3.300	0.154	0.130
е	1.27BSC		0.05	BSC
Н	0.650	0.380	0.026	0.015
К		1.100		0.043
L	0.710	0.380	0.028	0.015
L1	0.250	0.050	0.009	0.002
θ	12°	0°	12°	0°



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